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February 1999

## FDC658P

### Single P-Channel, Logic Level, PowerTrench™ MOSFET

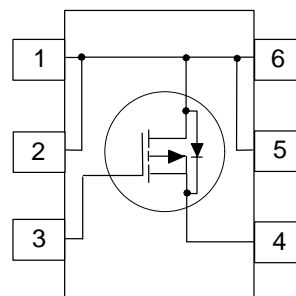
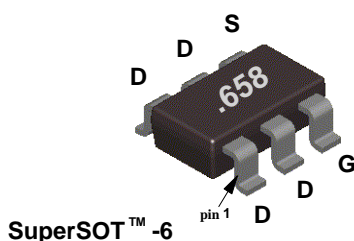
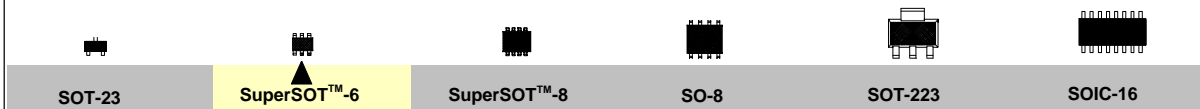
#### General Description

This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

#### Features

- 4 A, -30 V.  $R_{DS(ON)} = 0.050 \Omega @ V_{GS} = -10 V$   
 $R_{DS(ON)} = 0.075 \Omega @ V_{GS} = -4.5 V.$
- Low gate charge (8nC typical).
- High performance trench technology for extremely low  $R_{DS(ON)}$ .
- SuperSOT™-6 package: small footprint (72% smaller than standard SO-8); low profile (1mm thick).



#### Absolute Maximum Ratings

$T_A = 25^\circ C$  unless otherwise note

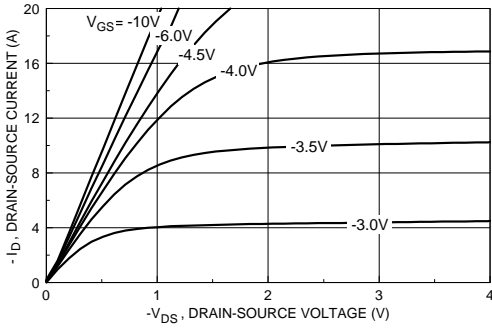
Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	-30	V
$V_{GSS}$	Gate-Source Voltage - Continuous	$\pm 20$	V
$I_D$	Drain Current - Continuous (Note 1a)	-4	A
	- Pulsed	-20	
$P_D$	Maximum Power Dissipation (Note 1a)	1.6	W
		(Note 1b)	
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 150	$^\circ C$

#### THERMAL CHARACTERISTICS

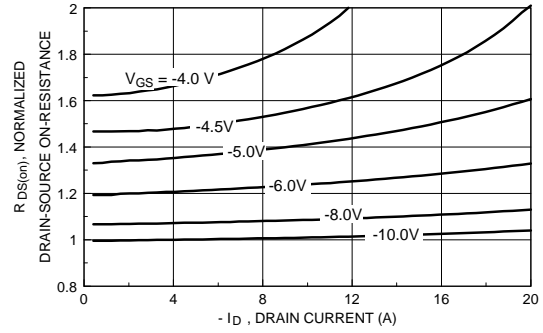
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	30	$^\circ C/W$

<b>ELECTRICAL CHARACTERISTICS</b> ( $T_A = 25^\circ\text{C}$ unless otherwise noted)						
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>OFF CHARACTERISTICS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = -250\ \mu\text{A}$	-30			V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-22		mV/°C
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$ $T_J = 55^\circ\text{C}$			-1	$\mu\text{A}$
					-10	$\mu\text{A}$
$I_{GSSF}$	Gate - Body Leakage, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA
$I_{GSSR}$	Gate - Body Leakage, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	nA
<b>ON CHARACTERISTICS</b> (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	-1	-1.7	-3	V
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		4.1		mV/°C
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = -10\text{ V}, I_D = -4.0\text{ A}$ $T_J = 125^\circ\text{C}$		0.041	0.05	$\Omega$
		$V_{GS} = -4.5\text{ V}, I_D = -3.4\text{ A}$		0.058	0.08	
				0.06	0.075	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = -10\text{ V}, V_{DS} = -5\text{ V}$	-20			A
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{ V}, I_D = -4\text{ A}$		9		S
<b>DYNAMIC CHARACTERISTICS</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = -15\text{ V}, V_{GS} = 0\text{ V}$		750		pF
$C_{oss}$	Output Capacitance	$f = 1.0\text{ MHz}$		220		pF
$C_{riss}$	Reverse Transfer Capacitance			100		pF
<b>SWITCHING CHARACTERISTICS</b> (Note 2)						
$t_{D(on)}$	Turn - On Delay Time	$V_{DD} = -15\text{ V}, I_D = -1\text{ A}$		12	22	ns
$t_r$	Turn - On Rise Time	$V_{GS} = -10\text{ V}, R_{GEN} = 6\ \Omega$		14	25	ns
$t_{D(off)}$	Turn - Off Delay Time			24	38	ns
$t_f$	Turn - Off Fall Time			16	27	ns
$Q_g$	Total Gate Charge	$V_{DS} = -15\text{ V}, I_D = -4.0\text{ A}$		8	12	nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = -5\text{ V}$		1.8		nC
$Q_{gd}$	Gate-Drain Charge			3		nC
<b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>						
$I_S$	Continuous Source Diode Current				-1.3	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -1.3\text{ A}$ (Note 2)		-0.76	-1.2	V
Notes:						
1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.						
a. $78^\circ\text{C/W}$ when mounted on a $1\text{ in}^2$ pad of 2oz Cu on FR-4 board.						
b. $156^\circ\text{C/W}$ when mounted on a minimum pad of 2oz Cu on FR-4 board.						
2. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$ , Duty Cycle $\leq 2.0\%$ .						

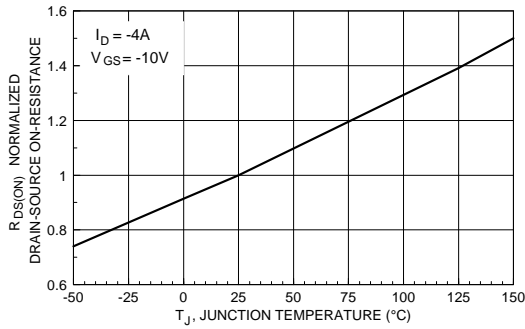
**Typical Electrical Characteristics**



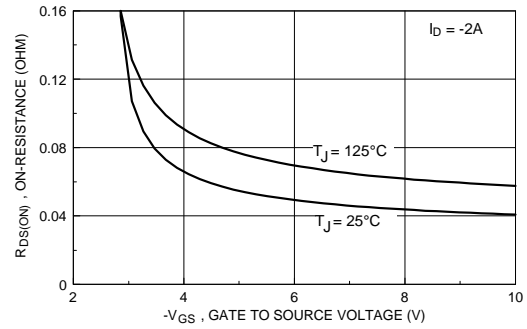
**Figure 1. On-Region Characteristics.**



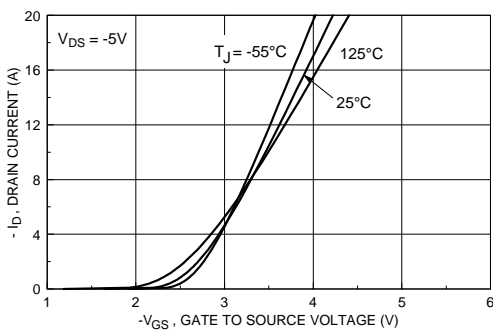
**Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.**



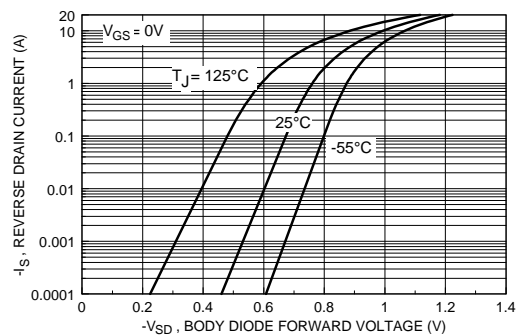
**Figure 3. On-Resistance Variation with Temperature.**



**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

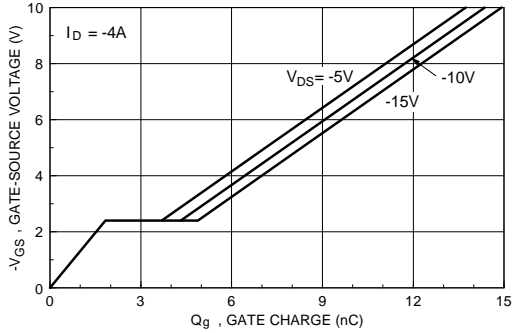


**Figure 5. Transfer Characteristics.**

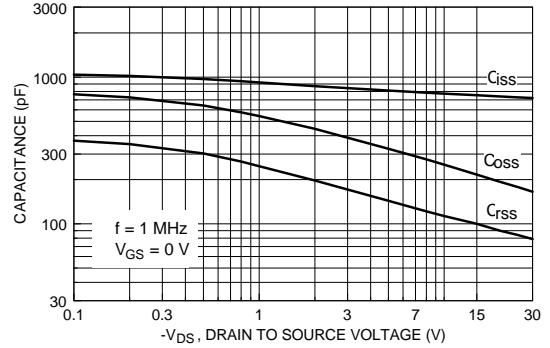


**Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.**

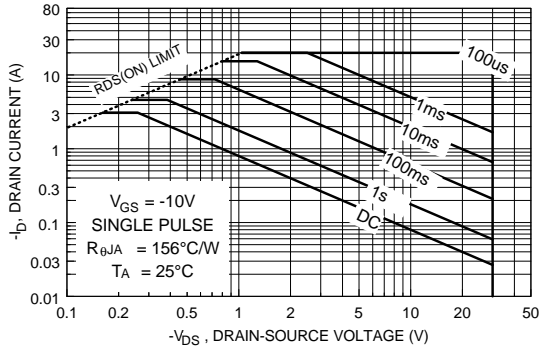
**Typical Electrical Characteristics (continued)**



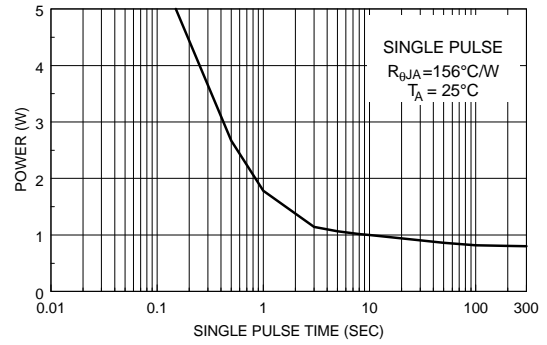
**Figure 7. Gate Charge Characteristics.**



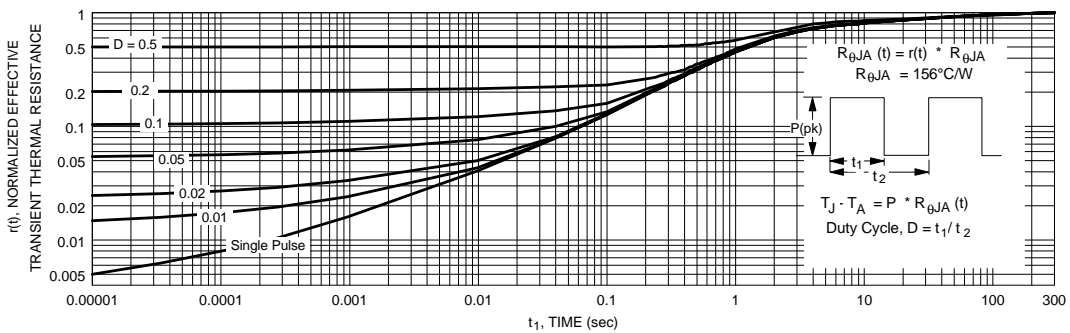
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1b.  
 Transient thermal response will change depending on the circuit board design.

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| FACT™                | QS™           |
| FACT Quiet Series™   | Quiet Series™ |
| FAST®                | SuperSOT™-3   |
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